

Teksan Co.

Light Spectroscopy Instruments

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For more information on any of our products or services please visit us on the Web.

Single Beam Spectrophotometer

High Resolution Low-Noise Spectrophotometer for Sensitive Applications

Full option and user-friendly computer program



Application Areas

- Engineering
- Food & Beverage Quality Control
- Chemistry
- Laser Characterization
- Biology
- Physics & Astronomy
- Protein & Nucleic Acid Analysis
- Volcanology
- Color Analysis
- Environments
- Nanotechnology
- Polymers

Spectrophotometry is a method to measure how much a chemical substance absorbs light by measuring the intensity of light as a beam of light passes through sample solution.

UV-Visible and NIR spectroscopy is a mature and well-established analytical technique used extensively in many industry sectors including Environmental Analysis, Pharmaceutical Testing, Food and Beverage Production to name but a few. Teksan manufactures an extensive range of UV and Visible and NIR Spectroscopy instrumentation guaranteed to meet the needs of your application. Further information on the UV-Vis-NIR product line along with a brief introduction to UV-Spectroscopy can be found in our website.

- High performance
- Low stray light
- High Wavelength accuracy
- blazed grating 300-600-1200lines/mm.
- Local control software for photometric fixed
- wavelength measurement.
- Easily upgraded to include quantitative analysis,
- multi wavelength spectrum & kinetics.
- Easy to use cell holder storage.
- Robust modular design with a small footprint.
- Can be used with WIN-Linux-MAC software.





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Features and Specifications

| ModeSingle BeamDetectionCCD Array (3648 Pixel)Wavelength Range280-950Optical Resolution1.7 nm (Configuration dependent)Light SourceDeuterium & Tungsten halogen lampAbsorbance0 to 3 AStray Light<0.03 %T |
|--|
| Wavelength Range280-950Optical Resolution1.7 nm (Configuration dependent)Light SourceDeuterium & Tungsten halogen lampAbsorbance0 to 3 AStray Light<0.03 %TWavelength Accuracy<±0.1 nmWavelength Reproducibility< ±0.02 nmPhotometric AccuracyUsing potassium dichromate, EP method < ± 0.01 APhotometric Noise (RMS)< 0.001 A 60 scan at 0 A, 500 nm |
| Optical Resolution 1.7 nm (Configuration dependent) Light Source Deuterium & Tungsten halogen lamp Absorbance 0 to 3 A Stray Light <0.03 %T Wavelength Accuracy <±0.1 nm Wavelength Reproducibility < ±0.02 nm Photometric Accuracy Using potassium dichromate, EP method < ± 0.01 A < 0.001 A 60 scan at 0 A, 500 nm |
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| |
| Photometric Stability <0.002 A/h after 1 hr warm un |
| co.002 A/II after 1 III warni-up |
| Baseline Flatness (RMS) <0.01 A - 0.5 sec blank, 0.5 sec scan |
| Scan Time 0.5 ms to 10 s |
| Typical Scan Time 20 ms |
| Software and System |
| Software Tunsu |
| Operational System Windows-Linux-MAC |
| Physical Dimensions (NO Hard case) |
| Size (W x D x H) 490 x 417 x 258 mm |
| Weight 15kg |
| Physical Dimensions (With Hard case) |
| Size (W x D x H) 590 x 517 x 358 mm |
| Weight 19kg |
| Power Requirements |
| Power Consumption 100 W |
| Line Voltage 220 V |
| Line Frequency 50-60 Hz |
| Environmental Conditions |
| Operating Temperature 5 − 35 °C |
| Non-Operating Temperature -20 − 50 °C |
| Humidity <95% @ 20-40 °C |

SERVICES AVAILABLE

Technical Support

Installation and Setup

Maintenance

Application Support

Hardware Support

Guaranteed Warranty

